

FAMILY OF LOW-POWER WIDE BANDWIDTH SINGLE SUPPLY OPERATIONAL AMPLIFIERS WITH SHUTDOWN

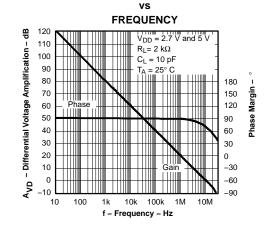
FEATURES

- CMOS Rail-To-Rail Output
- V_{ICR} Includes Positive Rail
- Wide Bandwidth . . . 11 MHz
- Slew Rate . . . 10 V/µs
- Supply Current . . . 800 μA/Channel
- Input Noise Voltage . . . 27 nV/√Hz
- Ultralow Power-Down Mode:
 I_{DD(SHDN}) = 4 μA/Channel
- Supply Voltage Range . . . 2.7 V to 5.5 V
- Specified Temperature Range: -40°C to 125°C . . . Industrial Grade
- Ultrasmall Packaging:
 5 or 6 Pin SOT-23 (TLV2620/1)
 8 or 10 Pin MSOP (TLV2622/3)
- Universal Opamp EVM (See SLOU060 for More Information)

Operational Amplifier



DIFFERENTIAL VOLTAGE AMPLIFICATION AND PHASE



DESCRIPTION

The TLV262x single supply operational amplifiers provide rail-to-rail output with an input range that includes the positive rail. The TLV262x takes the minimum operating supply voltage down to 2.7 V over the extended industrial temperature range (-40°C to 125°C) while adding the rail-to-rail output swing feature. The TLV262x also provides 11-MHz bandwidth from only 800 µA of supply current. The maximum recommended supply voltage is 5.5 V, which, when coupled with a 2.7-V minimum, allows the devices to be operated from lithium ion cells. The combination of wide bandwidth, low noise, and low distortion makes it ideal for high speed and high resolution data converter applications. The positive input range allows it to directly interface to positive rail referred systems. All members are available in PDIP and SOIC with the singles in the small SOT-23 package, duals in the MSOP, and quads in the TSSOP package.

The 2.7-V operation makes it compatible with Li-lon powered systems and the operating supply voltage range of many micro-power micro-controllers available today including Tl's MSP430.

AMPLIFIER SELECTION TABLE

DEVICE	V _{DD} [V]	I _{DD} /ch [μΑ]	V _{ιο} [μV]	I _{IB} [pA]	V _{ICR} [V]	GBW [MHz]	SLEW RATE [V/µs]	V _{n,} 1 kHz [nV/√ Hz]	I _O [mA]	SHUT- DOWN
TLV262x	2.7-5.5	750	250	1	1 V to V _{DD} + 0.2	11	10	27	28	Υ
TLV263x	2.7-5.5	750	250	1	GND to V _{DD} - 0.8	10	9	27	28	Υ
TLV278x	1.8-3.6	650	250	2.5	-0.2 to V _{DD} + 0.2	8	5	9	10	Υ
TLC07x	4.5 - 16	1900	60	1.5	0.5 to V _{DD} - 0.8	10	19	7	55	Υ
TLC08x	4.5 - 16	1900	60	3	GND to V _{DD} - 1	10	19	8.5	55	Y



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.





This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

TLV2620 AND TLV2621 AVAILABLE OPTIONS(1)

		PACKAGED DEVICES							
T _A	V _{IO} max AT 25°C	SMALL OUTLINE	SOT-23	DI ACTIC DID (D)					
	20 0	(D) ⁽²⁾	(DBV) ⁽³⁾	SYMBOL	PLASTIC DIP (P)				
-40°C to 125°C	3500 μV TLV2620ID TLV2621ID		TLV2620IDBV TLV2621IDBV	VBAI VBBI	TLV2620IP TLV2621IP				

- (1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.
- (2) This package is available taped and reeled. To order this packaging option, add an R suffix to the part number (e.g., TLV2620IDR).
- (3) The SOT23 package devices are only available taped and reeled. The R Suffix denotes quantities (3,000 pieces per reel). For smaller quantities (250 pieces per mini-reel), add a T suffix to the part number (e.g. TLV2620IDBVT).

TLV2622 AND TLV2623 AVAILABLE OPTIONS(1)

		PACKAGED DEVICES									
TΔ	T _A V _{IO} max AT 25°C	SMALL		PLASTIC	PLASTIC						
		OUTLINE ⁽²⁾ (D)	(DGK) ⁽²⁾	SYMBOL	(DGS) ⁽²⁾	SYMBOL	DIP (N)	DIP (P)			
-40°C to 125°C	3500 μV	TLV2622ID TLV2623ID	TLV2622IDGK —	xxTIAKM —	— TLV2623IDGS	 xxTIALC	 TLV2623IN	TLV2622IP —			

- For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI
 website at www.ti.com.
- (2) This package is available taped and reeled. To order this packaging option, add an R suffix to the part number (e.g., TLV2622IDR).

TLV2624 AND TLV2625 AVAILABLE OPTIONS(1)

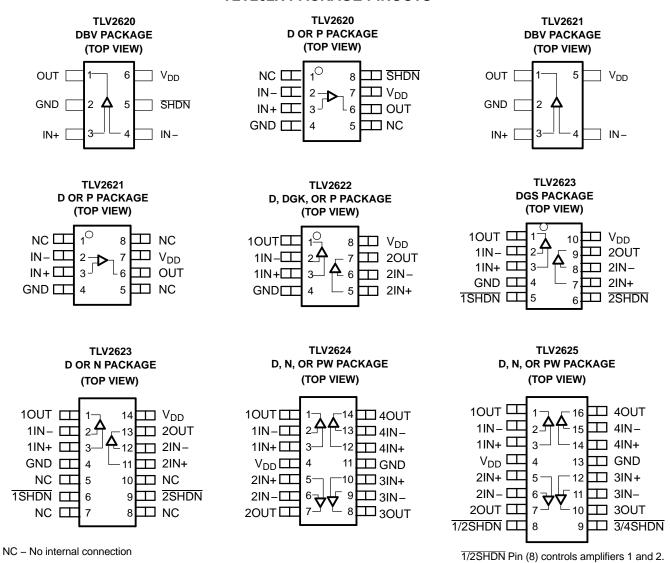
	V may	PACKAGED DEVICES					
T _A	V _{IO} max AT 25°C	SMALL OUTLINE (D) ⁽²⁾	PLASTIC DIP (N)	TSSOP (PW)			
-40°C to 125°C	3500 μV	TLV2624ID TLV2625ID	TLV2624IN TLV2625IN	TLV2624IPW TLV2625IPW			

- (1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.
- (2) This package is available taped and reeled. To order this packaging option, add an R suffix to the part number (e.g., TLV2624IDR).

3/4SHDN Pin (9) controls amplifiers 3 and 4.

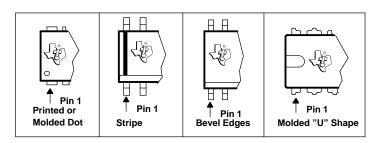


TLV262X PACKAGE PINOUTS(1)



(1) SOT-23 may or may not be indicated.

TYPICAL PIN 1 INDICATORS



NOTE:

If there is not a Pin 1 indicator, turn device to enable reading the symbol from left to right. Pin 1 is at the lower left corner of the device.



ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted)(1)

V_{DD}	Supply voltage (2)	6 V
V_{ID}	Differential input voltage	$\pm V_{DD}$
VI	Input voltage range (2)	+1 to V _{DD} + 0.2 V
I	Input current (any input)	± 10 mA
Io	Output current	±40 mA
	Continuous total power dissipation	See Dissipation Rating Table
T _A	Operating free-air temperature range: I-suffix	-40°C to 125°C
T_{J}	Maximum junction temperature	150°C
T _{stg}	Storage temperature range	-65°C to 150°C
	Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

⁽¹⁾ Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values, except differential voltages, are with respect to GND.

DISSIPATION RATING TABLE

PACKAGE	θJC (°C/W)	θ _{JA} (°C/W)	T _A ≤ 25°C POWER RATING	T _A = 125°C POWER RATING
D (8)	38.3	176	710 mW	142 mW
D (14)	26.9	122.3	1022 mW	204.4 mW
D (16)	25.7	114.7	1090 mW	218 mW
DBV (5)	55	324.1	385 mW	77.1 mW
DBV (6)	55	294.3	425 mW	85 mW
DGK (8)	54.2	259.9	481 mW	96.1 mW
DGS (10)	54.1	259.7	485 mW	97 mW
N (14, 16)	32	78	1600 mW	320.5 mW
P (8)	41	104	1200 mW	240.4 mW
PW (14)	29.3	173.6	720 mW	144 mW
PW (16)	28.7	161.4	774 mW	154.9 mW

RECOMMENDED OPERATING CONDITIONS

			MIN	MAX	UNIT
V	Supply voltage	Single supply	2.7	5.5	V
V_{DD}	Supply voltage Split	Split supply	±1.35	±2.75	
V_{ICR}	Common-mode input voltage range		1	V _{DD} +0.2	V
T_A	Operating free-air temperature	I-suffix	-40	125	°C
	Chutdown on/off voltage level(1)	V _{IL}		0.4	\/
	Shutdown on/off voltage level ⁽¹⁾	V _{IH}	2		٧

(1) Relative to GND.



ELECTRICAL CHARACTERISTICS

at specified free-air temperature, $V_{\rm DD}$ = 2.7 V, 5 V (unless otherwise noted)

	PARAMETER	TEST CONI	DITIONS	T _A ⁽¹⁾	MIN	TYP	MAX	UNIT	
DC PER	FORMANCE								
V	Input offset valtege			25°C		250	3500	\/	
V_{IO}	Input offset voltage	$V_{IC} = V_{DD}/2$, $V_O = V_{DD}$	/2,	Full range			4500	μV	
α_{VIO}	Temperature coefficient of input offset voltage	$R_S = 50 \Omega$		25°C		3		μV/°C	
				25°C	77	98			
		$V_{IC} = 1$ to V_{DD} ,	$V_{DD} = 2.7 \text{ V}$	Full range	63				
CMRR	Common-mode rejection ratio	$R_S = 50 \Omega$., _,,	25°C	78	99		dB	
			$V_{DD} = 5 V$	Full range	75				
		$V_{DD} = 2.7 \text{ V}, R_L = 2 \text{ kg}$	Ω,	25°C	90	100			
	Large-signal differential voltage	$V_{O(PP)} = 1.7 V$	Full range	82			-10		
A_{VD}	amplification	$V_{DD} = 5 \text{ V}, R_L = 2 \text{ k}\Omega,$		25°C	95	100		dB	
		$V_{O(PP)} = 4 V$	Full range	90					
NPUT C	CHARACTERISTICS	ı		,					
I	Input offset current			25°C		2	50		
I _{IO}	Input offset current	$V_{IC} = V_{DD}/2, V_O = V_{DD}$	/2,	Full Range			100	A	
Input bing ourrent		$R_S = 50\Omega$		25°C		2	50	pA	
IB	Input bias current			Full Range			200		
r _{i(d)}	Differential input resistance			25°C		100		GΩ	
C _{i(c)}	Common-mode input capacitance	f = 1 kHz		25°C		8		pF	
OUTPUT	CHARACTERISTICS	1					ļ.		
			V 0.7.V	25°C	2.6	2.67		V	
		$V_{IC} = V_{DD}/2,$	$V_{DD} = 2.7 \text{ V}$	Full range	2.55				
	High lovel output voltage	$I_{OH} = -1 \text{ mA}$	V 5 V	25°C	4.95	4.98			
V.			$V_{DD} = 5 V$	Full range	4.9				
V _{OH}	High-level output voltage		V _{DD} = 2.7 V	25°C	2.3	2.43			
		$V_{IC} = V_{DD}/2$,	v _{DD} = 2.7 v	Full range	2.2				
		I _{OH} = -10 mA	V _{DD} = 5 V	25°C	4.7	4.8			
			V _{DD} = 3 V	Full range	4.6				
			V _{DD} = 2.7 V	25°C		0.03	0.1		
		$V_{IC} = V_{DD}/2,$	VDD = 2.7 V	Full range			0.15		
		I _{OL} = 1 mA	V _{DD} = 5 V	25°C		0.025	0.05		
V _{OL}	Low-level output voltage		VDD = 3 V	Full range			0.1	V	
V OL	Low level output voltage		V _{DD} = 2.7 V	25°C		0.26	0.4	V	
		$V_{IC} = V_{DD}/2$,	VDD - 2.7 V	Full range			0.45		
		$I_{OL} = 10 \text{ mA}$	V _{DD} = 5 V	25°C		0.2	0.25		
			VDD = 3 V	Full range			0.35		
		$V_{DD} = 2.7 V,$	Sourcing			14		mA	
I _O Output current	Output current	$V_0 = 0.5 \text{ V from rail}$	Sinking	25°C		19			
	Output current	$V_{DD} = 5 V$,	Sourcing	25 C		28		ША	
		$V_O = 0.5 \text{ V from rail}$	Sinking			28			
-		Sourcing	V _{DD} = 2.7 V			50			
ı	Short circuit output ourrant	Sourcing	V _{DD} = 5 V	25∘€		95		mA	
los	Short-circuit output current	Cipking	V _{DD} = 2.7 V	25°C		50			
		Sinking $V_{DD} = 5 \text{ V}$		1		95			

⁽¹⁾ Full range is -40 $^{\circ}$ C to 125 $^{\circ}$ C for the I-suffix.



ELECTRICAL CHARACTERISTICS (continued)

at specified free-air temperature, V_{DD} = 2.7 V, 5 V (unless otherwise noted)

	PARAMETER	TEST CONDI	TIONS	T _A ⁽¹⁾	MIN	TYP	MAX	UNIT	
POWER S	SUPPLY								
	Complete company (non-phase and)	V V /0	SHDN = V _{DD}	25°C		800	1000		
I _{DD}	Supply current (per channel)	$V_O = V_{DD}/2$, $SHDN = V_{DD}$		Full range			1300	μA	
		$V_{DD} = 2.7 \text{ V to } 3.3 \text{ V},$		25°C	80	98			
PSRR	Supply voltage rejection ratio	$V_{IC} = V_{DD}/2$	No load	Full range	75			dB	
PSKK	$(\Delta V_{DD}/\Delta V_{IO})$	$V_{DD} = 2.7 \text{ V to 5 V},$	INO IOAG	25°C	75	90			
		$V_{IC} = V_{DD}/2$		Full range	70				
DYNAMIC	PERFORMANCE								
UGBW	Unity gain bandwidth	$R_L = 2 \text{ k}\Omega$, $C_L = 10 \text{ pF}$		25°C		11		MHz	
			$V_{DD} = 2.7 \text{ V},$	25°C	3.5	4.5			
CD.	Positive slew rate at unity gain	D 240 C 50 pF	$V_{O(PP)} = 1.7 \text{ V}$	Full range	2.7			V/µs	
SR+		$R_L = 2 k\Omega, C_L = 50 pF$	V _{DD} = 5 V,	25°C	5.4	7			
			$V_{O(PP)} = 3.5 \text{ V}$	Full range	3.4				
			V _{DD} = 2.7 V,	25°C	2.7	5			
CD	No active plantage at their active	D 01:0 0 50 = 5	$V_{O(PP)} = 1.7 \text{ V}$	Full range	2.3			1//	
SR-	Negative slew rate at unity gain	$R_L = 2 \text{ K}\Omega, C_L = 50 \text{ pr}$	V _{DD} = 5 V,	25°C	4.5	6		V/µs	
			$V_{O(PP)} = 3.5 \text{ V}$	Full range	3.2				
ϕ_{m}	Phase margin	D 240 C 10 pF		25°C		63°			
	Gain margin	$R_L = 2 k\Omega$, $C_L = 10 pF$		25°C		8		dB	
NOISE/DI	STORTION PERFORMANCE								
			A _V = 1		0	.002%			
THD + N	Total harmonic distortion plus noise	$V_{O(PP)} = V_{DD}/2$, $R_L = 2 k\Omega$, $f = 10 kHz$	A _V = 10		0	.019%			
	1.0.00		A _V = 100	25°C	0	.095%			
V	Equivalent input poice voltage	f = 1 kHz		25 C		53		nV/√ Hz	
V_n	Equivalent input noise voltage	f = 10 kHz				27		IIV/∀⊓Z	
In	Equivalent input noise current	f = 1 kHz				0.9		fA/√ Hz	
SHUTDO	WN CHARACTERISTICS								
Supply current, per channel in				25°C		4	11		
I _{DD(SHDN)}	shutdown mode (TLV2620, TLV2623, TLV2625)	<u>SHDN</u> = 0.4 V		Full range			13	μΑ	
+	Amplifier turnon time ⁽²⁾	$R_L = 2 k\Omega$	V _{DD} = 2.7 V			4.5			
t _(on)	Ampliner turnori time (=/	IV = 2 K22	V _{DD} = 5 V	25°C		1.5		μs	
t _(off)	Amplifier turnoff time ⁽²⁾	$R_L = 2 k\Omega$				200		ns	

⁽²⁾ Disable time and enable time are defined as the interval between application of the logic signal to SHDN and the point at which the supply current has reached half its final value.



TYPICAL CHARACTERISTICS

TABLE OF GRAPHS

			FIGURE
V _{IO}	Input offset voltage	vs Common-mode input voltage	1, 2
CMRR	Common-mode rejection ratio	vs Frequency	3
V _{OH}	High-level output voltage	vs High-level output current	4, 6
V _{OL}	Low-level output voltage	vs Low-level output current	5, 7
I _{DD}	Supply current	vs Supply voltage	8
I _{DD}	Supply current	vs Free-air temperature	9
PSRR	Power supply rejection ratio	vs Frequency	10
A _{VD}	Differential voltage amplification & phase	vs Frequency	11
	Gain-bandwidth product	vs Free-air temperature	12
0.0	Claurata	vs Supply voltage	13
SR	Slew rate	vs Free-air temperature	14, 15
φ _m	Phase margin	vs Load capacitance	16
V _n	Equivalent input noise voltage	vs Frequency	17
	Voltage-follower large-signal pulse response		18
	Voltage-follower small-signal pulse response		19
	Crosstalk	vs Frequency	20
I _{DD(SHDN)}	Shutdown supply current	vs Free-air temperature	21
I _{DD(SHDN)}	Shutdown supply current	vs Supply voltage	22
I _{DD(SHDN)}	Shutdown supply current/output voltage	vs Time	23

INPUT OFFSET VOLTAGE vs COMMON-MODE INPUT VOLTAGE

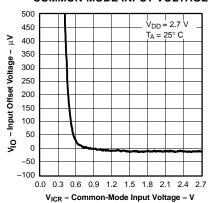


Figure 1.

INPUT OFFSET VOLTAGE vs COMMON-MODE INPUT VOLTAGE

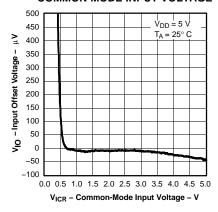


Figure 2.

COMMON-MODE REJECTION RATIO vs FREQUENCY

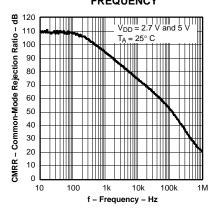
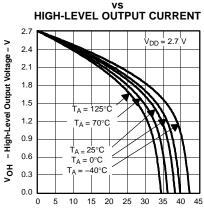
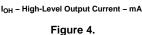


Figure 3.

HIGH-LEVEL OUTPUT VOLTAGE







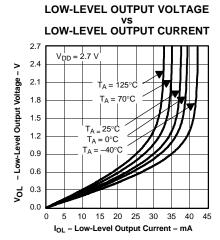
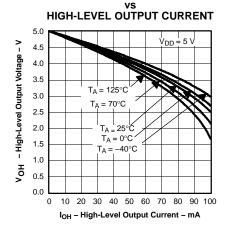


Figure 5.



HIGH-LEVEL OUTPUT VOLTAGE

Figure 6.



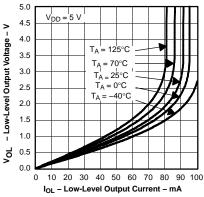


Figure 7.

SUPPLY CURRENT VS SUPPLY VOLTAGE

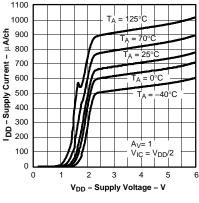


Figure 8.

SUPPLY CURRENT vs FREE-AIR TEMPERATURE

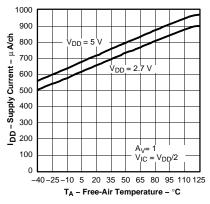


Figure 9.

POWER SUPPLY REJECTION RATIO vs FREQUENCY

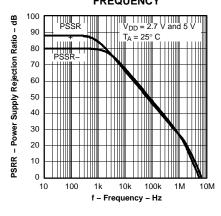


Figure 10.

DIFFERENTIAL VOLTAGE AMPLIFICATION AND PHASE VS FREQUENCY

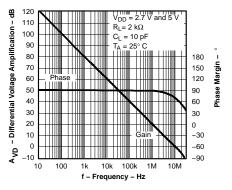


Figure 11.

GAIN-BANDWIDTH PRODUCT vs FREE-AIR TEMPERATURE

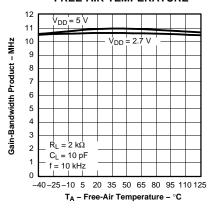
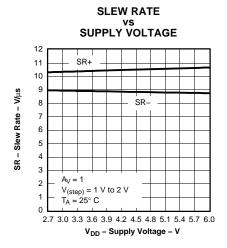
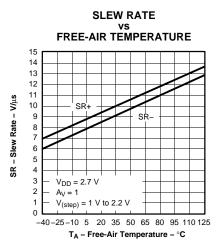


Figure 12.







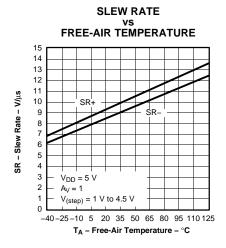
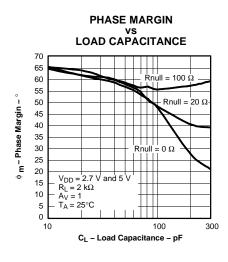
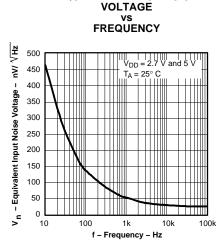


Figure 13.

Figure 14.

Figure 15.





EQUIVALENT INPUT NOISE

Figure 16.

Figure 17.

VOLTAGE-FOLLOWER LARGE-SIGNAL PULSE RESPONSE

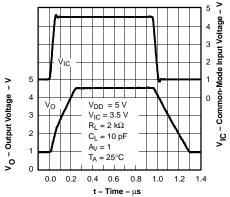


Figure 18.

VOLTAGE-FOLLOWER SMALL-SIGNAL PULSE RESPONSE

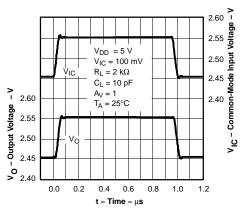
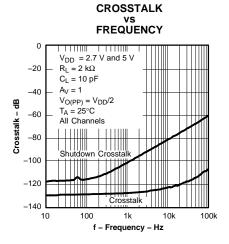
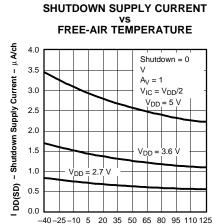


Figure 19.







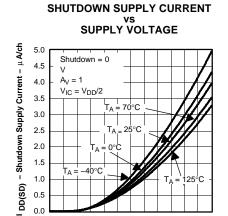


Figure 20. Figure 21.

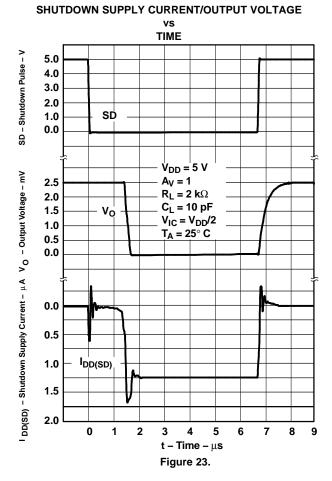
 T_A – Free-Air Temperature – $^{\circ}C$

Figure 22.

V_{DD} - Supply Voltage - V

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
TLV2620IDBVR	ACTIVE	SOT-23	DBV	6	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	VBAI	Samples
TLV2620IDBVT	ACTIVE	SOT-23	DBV	6	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	VBAI	Samples
TLV2620IDR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	26201	Samples
TLV2621IDBVR	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	VBBI	Samples
TLV2621IDBVT	ACTIVE	SOT-23	DBV	5	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	VBBI	Samples
TLV2621IDR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	26211	Samples
TLV2622ID	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	26221	Samples
TLV2622IDGKR	ACTIVE	VSSOP	DGK	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AKM	Samples
TLV2622IDR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	26221	Samples
TLV2623IDGS	ACTIVE	VSSOP	DGS	10	80	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	ALC	Samples
TLV2623IDGSR	ACTIVE	VSSOP	DGS	10	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	ALC	Samples
TLV2624ID	ACTIVE	SOIC	D	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	26241	Samples
TLV2624IDR	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	26241	Samples
TLV2624IPW	ACTIVE	TSSOP	PW	14	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	26241	Samples
TLV2624IPWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	26241	Samples

⁽¹⁾ The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.



PACKAGE OPTION ADDENDUM

www.ti.com 6-Apr-2024

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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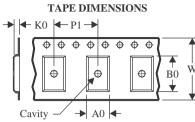
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www.ti.com 25-Sep-2024

TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLV2620IDBVR	SOT-23	DBV	6	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TLV2620IDBVT	SOT-23	DBV	6	250	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TLV2620IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLV2621IDBVR	SOT-23	DBV	5	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TLV2621IDBVT	SOT-23	DBV	5	250	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TLV2621IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLV2622IDGKR	VSSOP	DGK	8	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
TLV2622IDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLV2623IDGSR	VSSOP	DGS	10	2500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
TLV2624IDR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
TLV2624IPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1



www.ti.com 25-Sep-2024



*All dimensions are nominal

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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
TLV2620IDBVR	SOT-23	DBV	6	3000	182.0	182.0	20.0	
TLV2620IDBVT	SOT-23	DBV	6	250	182.0	182.0	20.0	
TLV2620IDR	SOIC	D	8	2500	340.5	338.1	20.6	
TLV2621IDBVR	SOT-23	DBV	5	3000	182.0	182.0	20.0	
TLV2621IDBVT	SOT-23	DBV	5	250	182.0	182.0	20.0	
TLV2621IDR	SOIC	D	8	2500	340.5	338.1	20.6	
TLV2622IDGKR	VSSOP	DGK	8	2500	358.0	335.0	35.0	
TLV2622IDR	SOIC	D	8	2500	353.0	353.0	32.0	
TLV2623IDGSR	VSSOP	DGS	10	2500	358.0	335.0	35.0	
TLV2624IDR	SOIC	D	14	2500	353.0	353.0	32.0	
TLV2624IPWR	TSSOP	PW	14	2000	356.0	356.0	35.0	

PACKAGE MATERIALS INFORMATION

www.ti.com 25-Sep-2024

TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
TLV2622ID	D	SOIC	8	75	507	8	3940	4.32
TLV2624ID	D	SOIC	14	50	507	8	3940	4.32
TLV2624IPW	PW	TSSOP	14	90	530	10.2	3600	3.5





NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
- 5. Reference JEDEC registration MS-012, variation AB.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-187, variation BA.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







NOTES:

- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.25 per side.

- 4. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation.
- 5. Refernce JEDEC MO-178.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 2. This drawing is subject to change without notice.
 3. Reference JEDEC MO-178.

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
- 5. Support pin may differ or may not be present.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







NOTES:

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- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-187.





- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- 8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
- 9. Size of metal pad may vary due to creepage requirement.





- 11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 12. Board assembly site may have different recommendations for stencil design.



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